

# AON2290 100V N-Channel MOSFET

# **General Description**

**Orderable Part Number** 

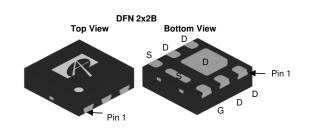
The AON2290 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\text{DS(ON)}}$ . This device is ideal for load switch and battery protection applications.

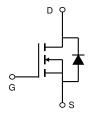
# **Product Summary**

 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 4.5A \\ R_{DS(ON)} \; (at \; V_{GS} = \! 10V) & < 72m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = \! 4.5V) & < 97m\Omega \end{array}$ 

Form







Minimum Order Quantity

AON2290		DFN 2x2B	Tape & Reel	3000			
Absolute Maximum	n Ratings T <sub>A</sub> =25°C unle	ss otherwise noted					
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V <sub>DS</sub>	100	V			
Gate-Source Voltage		V <sub>GS</sub>	±20	V			
Continuous Drain	T <sub>A</sub> =25°C		4.5				
Current	T <sub>A</sub> =70°C	'D	3.5	A			
Pulsed Drain Current C		I <sub>DM</sub>	25				
	T <sub>A</sub> =25°C	В	2.8	W			
Power Dissipation A	T <sub>A</sub> =70°C	P <sub>D</sub>	1.8	VV			
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C			

Package Type

Thermal Characteristics							
Parameter	Symbol	Тур	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	37	45	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	66	80	°C/W		
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	6.5	8.0	°C/W		



### Electrical Characteristics (T<sub>.I</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Conditions		Тур	Max	Units		
STATIC PARAMETERS									
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		100			V		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V	T,1=55°C			1 5	μА		
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}=0V$ , $V_{GS}=\pm20V$	, ,			±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{D}=250\mu A$			2.3	2.8	V		
I <sub>D(ON)</sub>	On state drain current	$V_{GS}=10V, V_{DS}=5V$		25			Α		
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}$ =10V, $I_D$ =4.5A	T <sub>.i</sub> =125°C		59 110	72 134	mΩ		
	Static Diam-Source Off-Resistance	$V_{GS}$ =4.5V, $I_{D}$ =4A	1 J=123 C		77	97	mΩ		
9 <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V$ , $I_D=4.5A$			13		S		
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.78	1	V		
Is	Maximum Body-Diode Continuous Curr	rent			3.5	Α			
DYNAMIC	PARAMETERS				•				
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =50V, f=1MHz			415		рF		
C <sub>oss</sub>	Output Capacitance				32		pF		
$C_{rss}$	Reverse Transfer Capacitance				3		pF		
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz			1.4		Ω		
SWITCHI	NG PARAMETERS								
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =4.5A			6.5	12	nC		
Q <sub>g</sub> (4.5V)	Total Gate Charge				3	6	nC		
$Q_{gs}$	Gate Source Charge				1.5		nC		
$Q_{gd}$	Gate Drain Charge				1.5		nC		
t <sub>D(on)</sub>	Turn-On DelayTime				4		ns		
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_L$ =11 $\Omega$ , $R_{GEN}$ =3 $\Omega$			2		ns		
$t_{D(off)}$	Turn-Off DelayTime				15		ns		
t <sub>f</sub>	Turn-Off Fall Time				2		ns		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =4.5A, dI/dt=500A/μs			16		ns		
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F$ =4.5A, dI/dt=500A/ $\mu$ s			44		nC		

A. The value of  $R_{\rm BJA}$  is measured with the device mounted on  $1 \, \text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on R  $_{0JA}$  t  $\leq$  10s value and the maximum allowed junction temperature of 150 $^{\circ}$  C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J_j(MAX)}=150^\circ$  C. Ratings are based on low frequency and duty cycles to keep initial  $T_J = 25^{\circ}$  C.

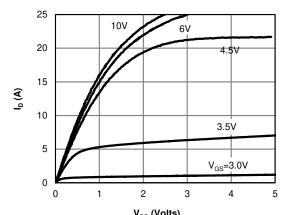
D. The  $R_{NJC}$  is the sum of the thermal impedance from junction to case  $R_{NJC}$  and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu$ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of TJ(MAX)=150° C. The SOA curve provides a single pulse rating. G. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of TJ(MAX)=150° C.

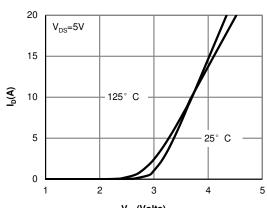
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



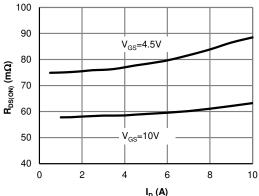
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



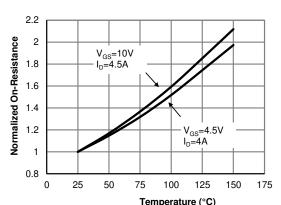
V<sub>DS</sub> (Volts)
Fig 1: On-Region Characteristics (Note E)



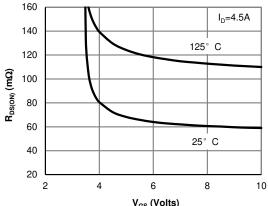
V<sub>GS</sub>(Volts)
Figure 2: Transfer Characteristics (Note E)



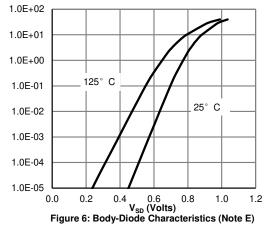
I<sub>D</sub> (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



I<sub>s</sub>(A)



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

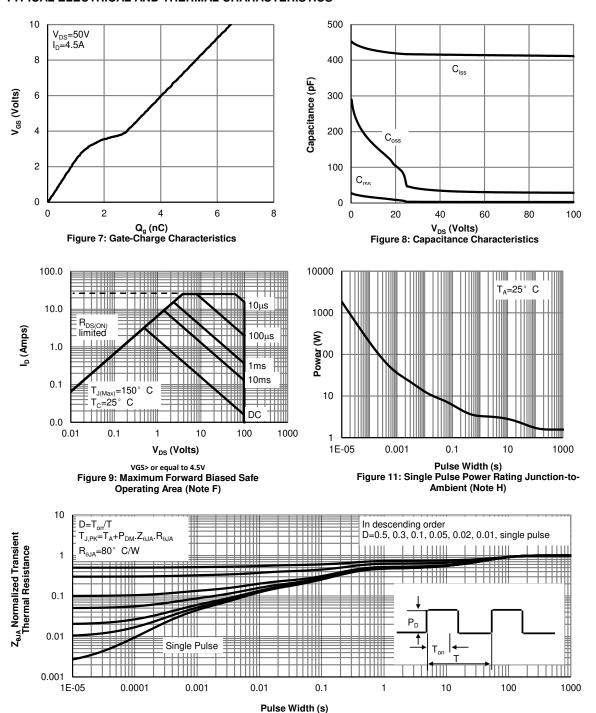
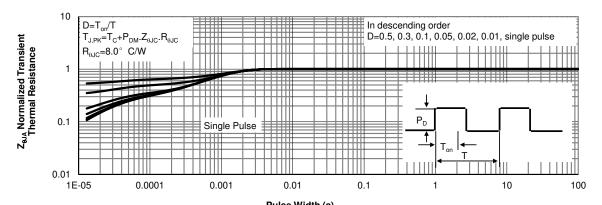


Figure 12: Normalized Maximum Transient Thermal Impedance (Note H)



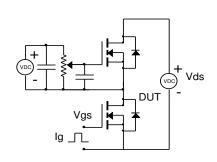
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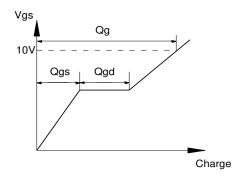


Pulse Width (s)
Figure 13: Normalized Maximum Transient Thermal Impedance (Note G

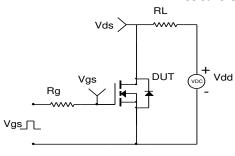


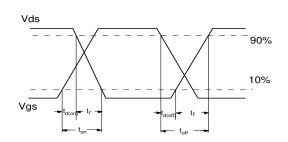
# Gate Charge Test Circuit & Waveform





# Resistive Switching Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

